Facile Template-free Preparation of Silvercoated Cu₃SbS₄ Hollow Spheres with Enhanced Photoelectric Properties

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Figure S1. XRD patterns of the as-synthesized (a) $Cu_{12}Sb_4S_{13}$, (b) Cu_3SbS_3 and (c) $CuSbS_2$ by solvothermal method along with the standard reference pattern as #24-1318, #31-0450 and #44-1417, respectively, SEM images of (a') $Cu_{12}Sb_4S_{13}$, (b') Cu_3SbS_3 and (c') $CuSbS_2$. High-purity Cu-Sb-S phases were formed and distinguishing morphology (including configuration and size) could be recognized from SEM images.



Figure S2. XPS spectra of the as-synthesized $Cu_{12}Sb_4S_{13}$ nanocrystals including the survey spectrum along with the corresponding high-resolution XPS spectra for Cu 2p, Sb 3d and S 2p core levels.

Calculation of Ag content:

The relative content of Ag and Cu_3SbS_4 in the composites can be calculated by the K value method, and the formula is described as follows¹:

$I_A/I_S = k \times W_A/W_S$

Where I is the diffraction peak intensity, W is the weight percentage, and k is a constant value. The k value could be obtained from the standard PDF card. Both 0.5 vol% Ag and 1 vol% Ag content in the composites could be roughly estimated from XRD patterns.



Figure S3. EDS result for the elemental mapping image along with the relative chemical composition of the as-synthesized Ag-coated Cu_3SbS_4 nanocrystals hollow spheres.



Figure S4. XPS spectra of the as-synthesized Ag-coated Cu_3SbS_4 nanocrystals hollow spheres including the survey spectrum along with the corresponding high-resolution XPS spectra for Cu 2p, Sb 3d, Ag 2d and S 2p core levels. A relatively small satellite peak at 530.6 eV appeared, which means a very little reduction of Sb⁵⁺ into Sb³⁺ by sodium borohydride. The change has not been mentioned in the main body due to a relatively small change.



Figure S5. (a) UV-Vis-NIR spectra of Ag nanoparticles, Cu_3SbS_4 powder by melting method, Cu_3SbS_4 nanocrystals hollow spheres, 0.5 vol % Ag-coated Cu_3SbS_4 and 1 vol % Ag-coated Cu_3SbS_4 , the corresponding Tauc plot of $(\alpha hv)^{1/2}$ versus (hv) of the as-synthesized (b) Cu_3SbS_4 nanocrystals hollow spheres and (c) Ag-coated ones.

Given the absorption spectrum of Ag clusters, the Ag nanoparticles with sphere structure possessed a broad peak at 400 nm for surface plasmon resonance². The broad peaks located around 320 nm and 900 nm attributed to the in-plane dipole plasmon and out-of-plane quadrupole resonances, respectively, which suggested the formation of Ag with triangular nanoprism structure³. This could be possibly aroused from geometry of Cu_3SbS_4 nanoparticles precursor.

Calculation of optical band gap:

The optical bandgap of the film is determined from the absorption coefficient using

$$\alpha^m = A(h\nu - E_g) \tag{1}$$

where A is a constant, m is the transition probability, E_g is the optical band gap⁴. The value of n could be 1/2 or 2 for allowed indirect or direct transitions, respectively. From the experimental results and theoretical calculations for band structure, n = 1/2 for Cu₃SbS₄ with an indirect transition was chosen^{5–8}. The bandgap of samples is determined from the plot of $(\alpha \cdot hv)^2$ versus photon energy by extrapolating to $\alpha \cdot hv = 0$.



Figure S6. XRD pattern of the as-synthesized bulk Cu_3SbS_4 by melting method, a small quantity of $Cu_{12}Sb_4S_{13}$ was detected. Polycrystalline sample of Cu_3SbS_4 was synthesized by the stoichiometric amount of high purity elements (>99.99%) at 1173K for 24h, cooled down to 673K and held on for 2d. The obtained ingots were hand-ground into fine powder for hot pressing at 673 K for 20 min under a uniaxial pressure of 80 MPa.



Figure S7. SEM images of the smaller spherical aggregation of crystals by only 5 min duration

time at high temperature

Table	S1.	The	representative	preparation	method,	structural	properties	and	optical	band	gap
(indirect) of Cu ₃ SbS ₄											

Method	Size of crystals (nm)	Shape of crystals	Form	valence state	Optical band gap (eV)	Application	Ref.
Solvothermal method	200	-	Powder		1	-	9
Solvothermal method	26-32	sphere	Powder		0.88-1	-	10
Solvothermal method	20	-	Film (SC)		0.82	-	11
hydrothermal	40-60 in thickness	nanofibers	Powder		-	-	12
Hot-injection	$10.2{\pm}1.1$	spherical	Powder	132	0.9	-	6
Hot-injection	10	spherical	Powder	132	1	-	13
Hot-injection	10.5±1.7	spherical	Powder		1.72	-	14
Hot-injection	23±4	oblates	Powder		1.2	-	5
Hot-injection	61±19	irregular to tetragonal	Powder	132	1.33	-	15
	5.95±0.67		Powder		1.5		7
Hot-injection	4.81±0.52	dots			1.6	-	
	3.37±0.46	_			1.7	-	
Hot-injection	4.72±0.52	Quasi- spherical	Powder		1.4	For optoelectronic devices	16
Hot-injection	14-20	-	Film (spray deposited method using chlorobenze ne)		0.89	Hole transporting material in solar cells	17
Hot-injection	21.5±8.0	Round-like	Powder		≥1	-	8
Hot-injection	19	-	Film (SC)	152	0.9	Absorber layer in TFSC	18
Microwave radiation	30-50	sphere-like	Powder	152	1.1	-	19
Mechanical alloying with spark plasma sintering	≥1000	-	Powder	152	0.85	Thermoelectric materials	20
Deep eutectic solvents synthetic approach	~7	nearly spherical	-	152	1.23	Water-splitting	21
RF magnetron sputtering with Sulfurization	≥1000	-	Film		0.89±0.01	-	22
Electron-beam evaporation with Sulfurization	≥1000	-	Film		0.88	-	23
Magnetron	50±30	-	Film		0.94-0.97	For TFSC	24

sputter with Sulfurization

Where, TFSC is the abbreviation for thin film solar cells, SC is the abbreviation for spin-coating, ≥ 1000 means that the size of crystals was calculated roughly by us from SEM results in these papers and close to micrometer. The form is the state of Cu₃SbS₄ when the UV-Vis measurement was conducted. Three numbers in valence state column are corresponding to valence states of element Cu, Sb and S in Cu₃SbS₄, respectively.

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